

## 650V Silicon Carbide Power MOSFET

### Features

- Revolutionary semiconductor material Silicon Carbide
- High blocking voltage with low on-resistance
- High-speed switching with very low switching losses
- High-speed and high robust intrinsic body diode

### Product Summary

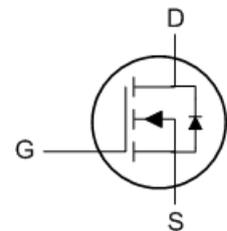
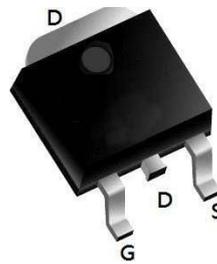


BVDSS	RDSON	ID
650V	180mΩ	19.5A

### Applications

- LED Driver
- PD charger
- PC adapter
- Air-conditioning
- E-bike charger

### TO252-3L Pin Configuration



### Maximum Ratings For MOSFET ( $T_{VJ} = 25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Testing Conditions
$V_{DSS}$	Drain-Source Voltage	650	V	
$I_D$	Continuous DC Drain Current for $R_{th(j-c,typ)}$ , Limited by $T_{VJ(max)}$	19.5	A	$T_C = 25^{\circ}\text{C}$
		13.5		$T_C = 100^{\circ}\text{C}$
$I_{DM}$	Peak Drain Current, tp Limited by $T_{VJ(max)}$	34	A	$T_C = 25^{\circ}\text{C}$
$V_{GS, max}$	Gate-Source Max Voltage	-10/22	V	
$V_{GS, op}$	Gate-Source Operate Voltage	0/15	V	
$E_{AS}$	Single Pulse Avalanche Energy	33.4	mJ	$L=0.5\text{mH}$ , $I_{AS}=11.5\text{A}$ , $V_{DD}=50\text{V}$ , $V_{GS}=15\text{V}$
$P_{tot}$	Power Dissipation for $R_{th(j-c,typ)}$	76	W	$T_C = 25^{\circ}\text{C}$

### Package Values

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions
$R_{th(j-c)}$	MOSFET/Body Diode Junction-Case Thermal Resistance		1.98	2.37	K/W	
$T_{VJ}$ , $T_{STG}$	Operating Junction and Storage Temperature	-55		175	$^{\circ}\text{C}$	
$T_{SOLD}$	Soldering Temperature, Wave Soldering only Allowed at Leads 1.6mm from Case for 10s		260		$^{\circ}\text{C}$	

**650V Silicon Carbide Power MOSFET**
**MOSFET Characteristics** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$I_D = 100 \mu\text{A}$	
$V_{GS(th)}$	Gate Threshold Voltage	3.2	3.9	5.0	V	$V_{DS} = V_{GS}, I_D = 10 \text{ mA}$	$T_{VJ} = 25^{\circ}\text{C}$
			2.8				$T_{VJ} = 175^{\circ}\text{C}$
$I_{DSS}$	Drain-Source Leakage Current		0.1	20	$\mu\text{A}$	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$	$T_{VJ} = 25^{\circ}\text{C}$
			5				$T_{VJ} = 175^{\circ}\text{C}$
$I_{GSS}$	Gate-Source Leakage Current			250	nA	$V_{GS} = 22 \text{ V}, V_{DS} = 0 \text{ V}$	$T_{VJ} = 25^{\circ}\text{C}$
$I_{SGS}$	Source-Gate Leakage Current			250	nA	$V_{GS} = -10 \text{ V}, V_{DS} = 0 \text{ V}$	$T_{VJ} = 25^{\circ}\text{C}$
$R_{DS(on)}$	Drain-Source On-State Resistance		180	215	m $\Omega$	$V_{GS} = 15 \text{ V}, I_D = 7 \text{ A}$	$T_{VJ} = 25^{\circ}\text{C}$
			164				$T_{VJ} = 175^{\circ}\text{C}$
$g_{fs}$	Transconductance		4.3		S	$V_{DS} = 20 \text{ V}, I_D = 7 \text{ A}$	
$R_{G(int)}$	Internal Gate Resistance		31		$\Omega$	$f = 1 \text{ MHz}, V_{AC} = 25 \text{ mV}$	
$C_{iss}$	Input Capacitance		418		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}, f = 1 \text{ MHz}$	
$C_{oss}$	Output Capacitance		33		pF		
$C_{rss}$	Reverse Transfer Capacitance		4.3		pF		
$Q_{GS}$	Gate to Source Charge		5.5		nC		
$Q_{GD}$	Gate to Drain Charge		2.6		nC	$V_{GS} = 0 / 15 \text{ V}, V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}$	
$Q_G$	Total Gate Charge		15.3		nC		

**Dynamic MOSFET Characteristics** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
$t_{d(on)}$	Turn-On Delay Time		29.2		ns	$V_{GS} = 0 / 15 \text{ V}, L = 600 \mu\text{H}$	$T_{VJ} = 25^{\circ}\text{C}$
			27.6				$T_{VJ} = 175^{\circ}\text{C}$
$t_r$	Rise Time		11.7		ns	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			10.8				$T_{VJ} = 175^{\circ}\text{C}$
$t_{d(off)}$	Turn-Off Delay Time		46.1		ns	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			43.1				$T_{VJ} = 175^{\circ}\text{C}$
$t_f$	Fall Time		16.5		ns	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			13.3				$T_{VJ} = 175^{\circ}\text{C}$
$E_{on}$	Turn-On Switching Loss		67.8		$\mu\text{J}$	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			67.5				$T_{VJ} = 175^{\circ}\text{C}$
$E_{off}$	Turn-Off Switching Loss		15.0		$\mu\text{J}$	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			10.5				$T_{VJ} = 175^{\circ}\text{C}$
$E_{tot}$	Total Switching Energy		82.8		$\mu\text{J}$	$V_{DD} = 400 \text{ V}, I_D = 7 \text{ A}, R_{G(on)} = 2.2 \Omega, R_{G(off)} = 2.2 \Omega$	$T_{VJ} = 25^{\circ}\text{C}$
			78.0				$T_{VJ} = 175^{\circ}\text{C}$

Note:  $E_{on}/E_{off}$  result is with body diode.

**Maximum Ratings For Body Diode** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise specified)

Symbol	Parameter	Value	Unit	Testing Conditions
$V_{DSS}$	Drain-Source Voltage	650	V	
$I_S$	Continuous DC Source Current, Limited by $T_{VJ(max)}$	13.5	A	$T_C = 25^{\circ}\text{C}$
		7.7	A	$T_C = 100^{\circ}\text{C}$
$I_{SM}$	Peak Reverse Drain Current, $t_p$ Limited by $T_{VJ(max)}$	29.5	A	$T_C = 25^{\circ}\text{C}$

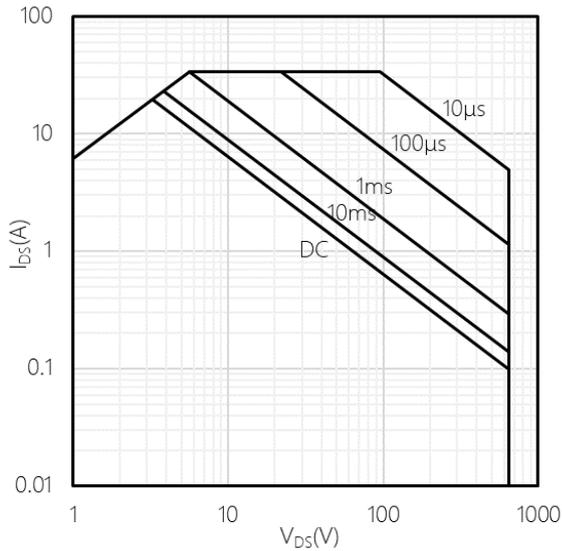
**650V Silicon Carbide Power MOSFET**
**Body Diode Characteristics** ( $T_{VJ} = 25^{\circ}\text{C}$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Testing Conditions	
$V_{SD}$	Body Diode Forward Voltage		3.3		V	$V_{GS} = 0\text{ V}, I_{SD} = 3.5\text{ A}$	$T_{VJ} = 25^{\circ}\text{C}$
			2.8				$T_{VJ} = 175^{\circ}\text{C}$
$I_{rrm}$	Peak Reverse Recovery Current		6.9		A	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V},$ $I_{SD} = 7\text{ A}, di/dt = 2\text{ kA}/\mu\text{s}$	$T_{VJ} = 25^{\circ}\text{C}$
			5.8				$T_{VJ} = 175^{\circ}\text{C}$
$Q_{rr}$	Reverse Recovery Charge		68		nC		$T_{VJ} = 25^{\circ}\text{C}$
			82				$T_{VJ} = 175^{\circ}\text{C}$
$t_{rr}$	Reverse Recovery Time		26		ns		$T_{VJ} = 25^{\circ}\text{C}$
			27				$T_{VJ} = 175^{\circ}\text{C}$
$E_{rr}$	Reverse Recovery Energy		5.0		$\mu\text{J}$		$T_{VJ} = 25^{\circ}\text{C}$
			7.2				$T_{VJ} = 175^{\circ}\text{C}$

Typical Performances

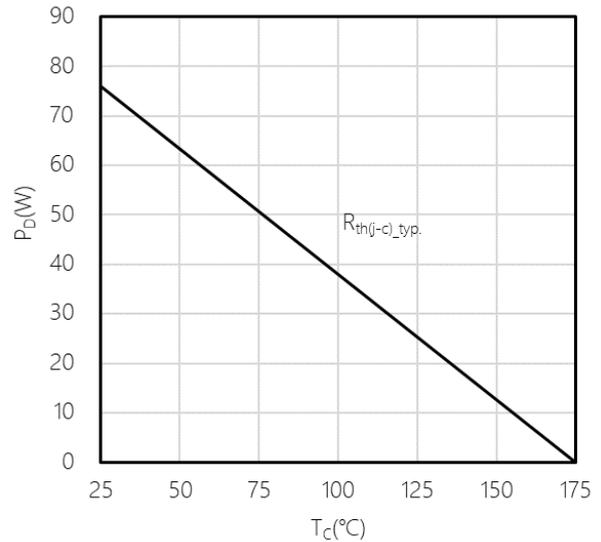
Safe operating area (SOA)

$R_{th(j-c)} = 2.37 \text{ }^\circ\text{C/W}$ , Single Pulse,  $T_{vj} = 25^\circ\text{C}$



Power dissipation as a function of case temperature limited by bond wire

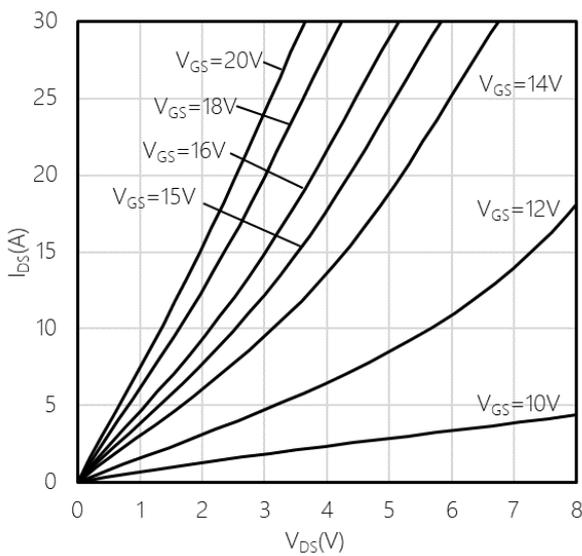
$P_D = f(T_c)$



Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$

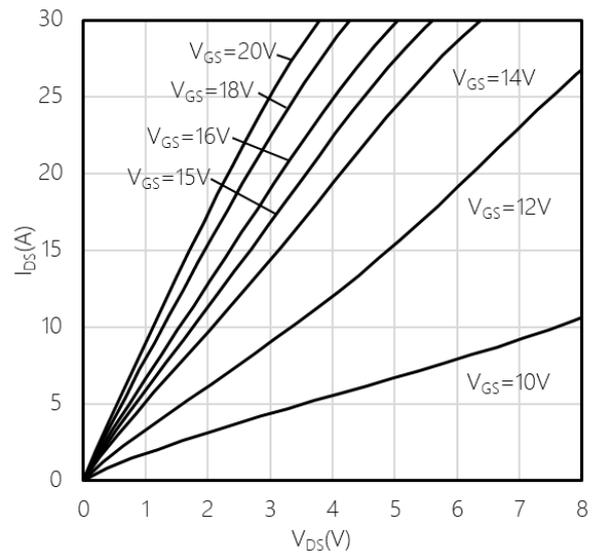
$T_{vj} = -55 \text{ }^\circ\text{C}$



Typical output characteristic,  $V_{GS}$  as parameter

$I_{DS} = f(V_{DS})$

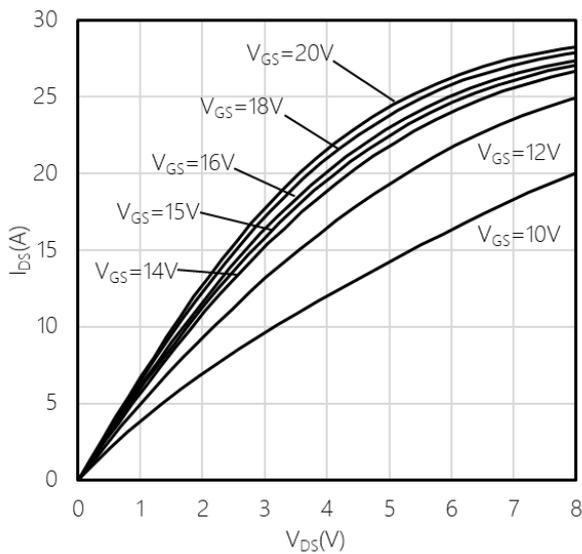
$T_{vj} = 25 \text{ }^\circ\text{C}$



**Typical output characteristic,  $V_{GS}$  as parameter**

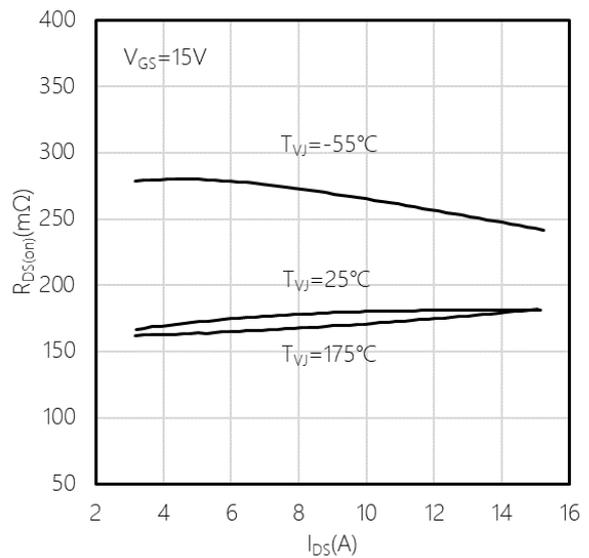
$I_{DS} = f(V_{DS})$

$T_{VJ} = 175^{\circ}\text{C}$



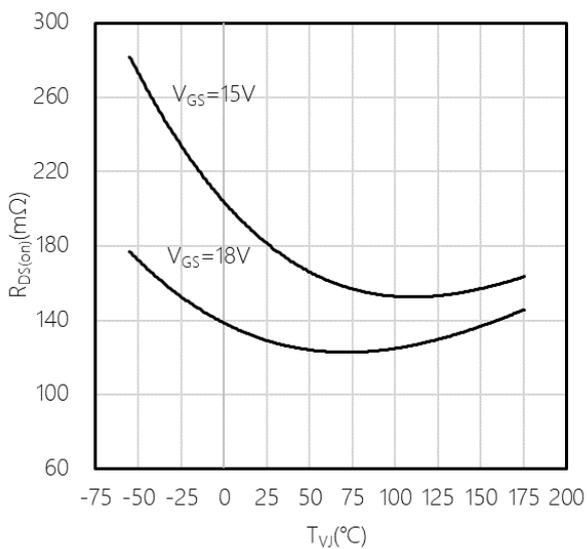
**Typical on-state resistance as a function of drain current**

$R_{DS(on)} = f(I_{DS}), V_{GS} = 15\text{V}$



**Typical on-state resistance as a function of temperature**

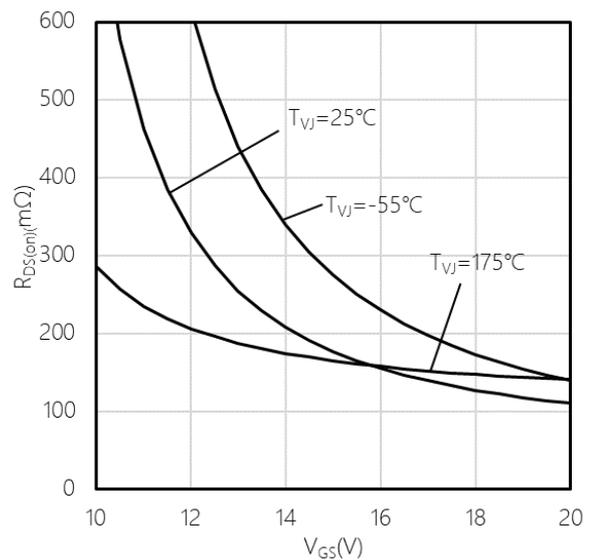
$R_{DS(on)} = f(T_{VJ}), I_{DS} = 7\text{ A}$



**Typical on-state resistance as a function of  $V_{GS}$**

$R_{DS(on)} = f(V_{GS})$

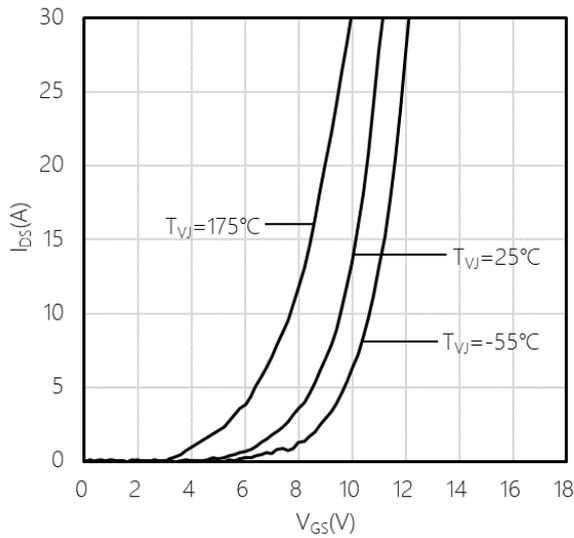
$I_{DS} = 7\text{ A}$



**Typical transfer characteristic**

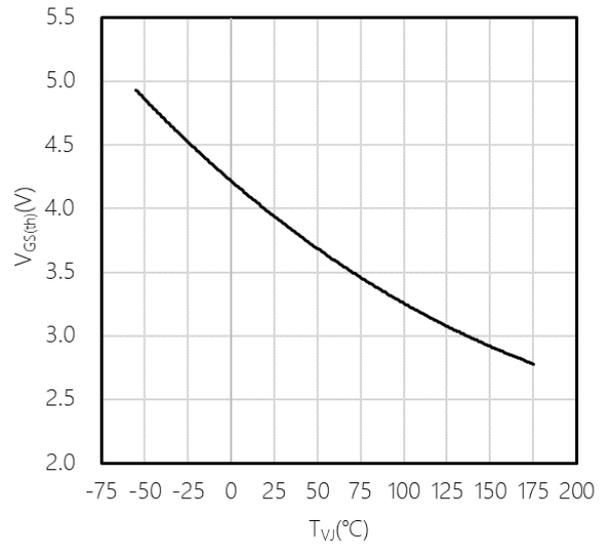
$I_{DS} = f(V_{GS})$

$V_{DS} = 20\text{ V}$



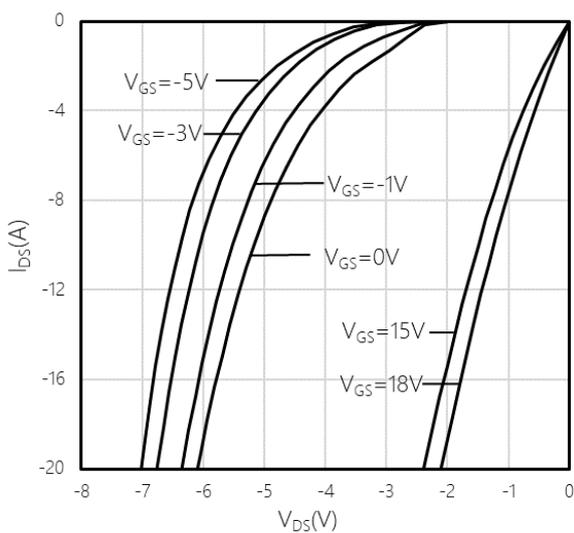
**Typical gate-source threshold voltage as a function of junction temperature**

$V_{GS(th)} = f(T_{Vj}), I_{DS} = 10\text{ mA}$



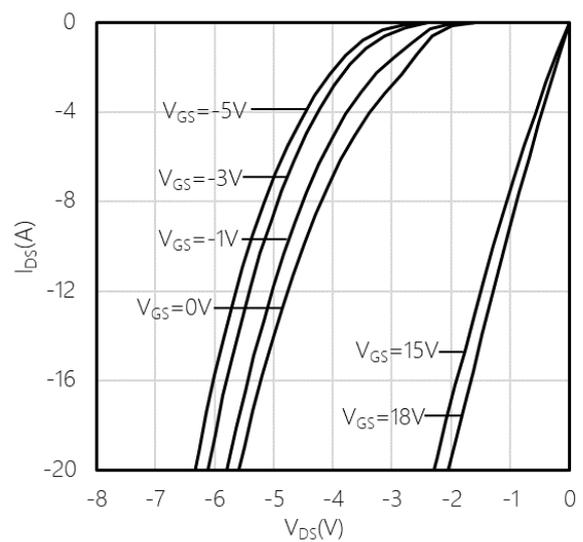
**Typical reverse drain current as function of reverse drain voltage, V\_GS as parameter**

$I_{DS} = f(V_{DS}), T_{Vj} = -55\text{ °C}$



**Typical reverse drain current as function of reverse drain voltage, V\_GS as parameter**

$I_{DS} = f(V_{DS}), T_{Vj} = 25\text{ °C}$

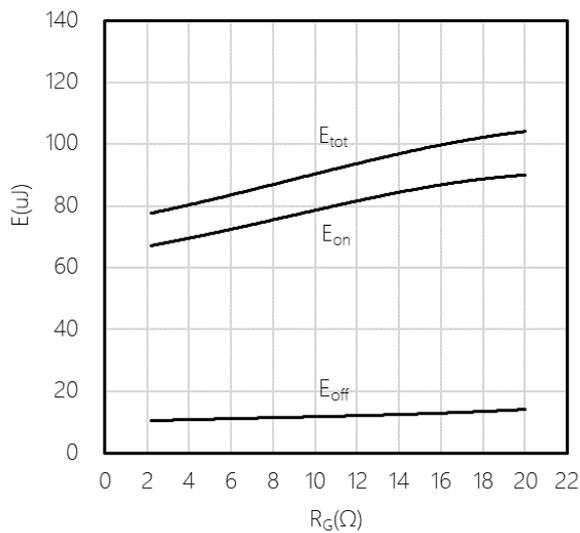


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Typical switching energy losses as a function of gate resistance, 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(R_{G(ext)})$

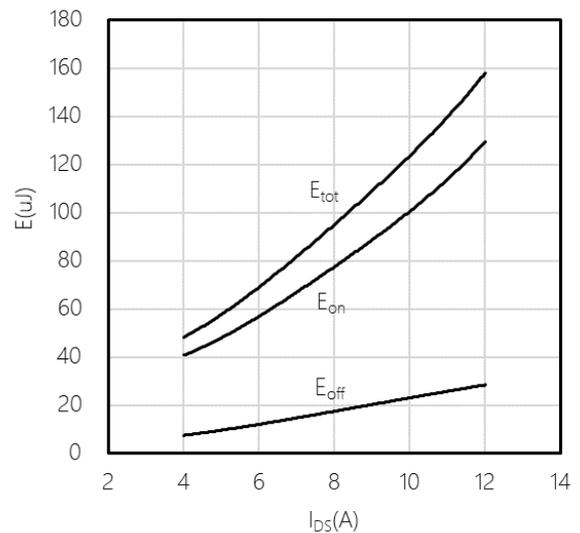
$V_{GS} = 0/15\text{ V}$ ,  $I_{DS} = 7\text{ A}$ ,  $T_{VJ} = 175\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $I_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(I_{DS})$

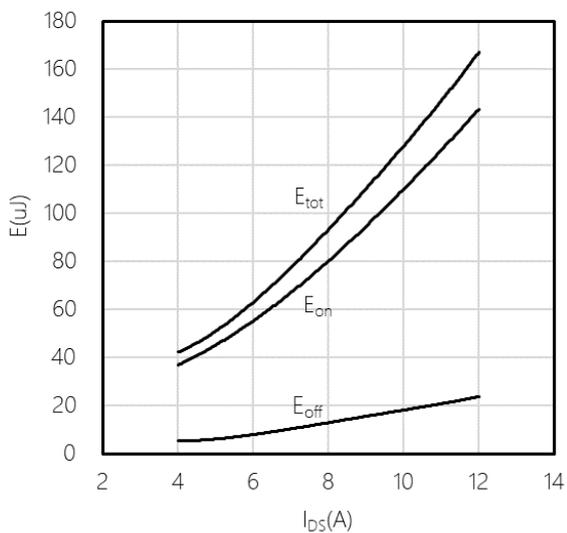
$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ }\Omega$ ,  $T_{VJ} = 25\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $I_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(I_{DS})$

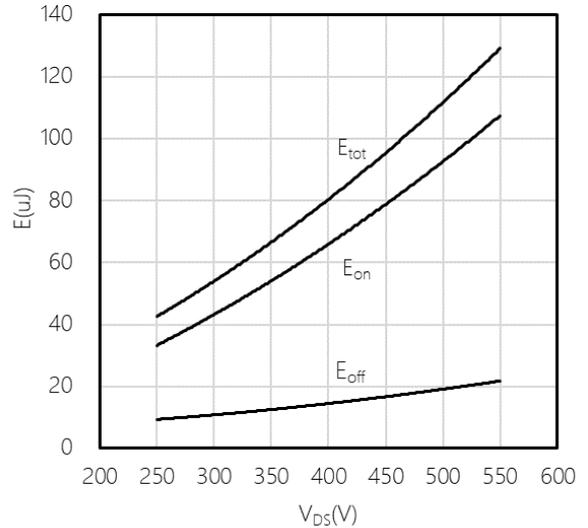
$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ }\Omega$ ,  $T_{VJ} = 175\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $V_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(V_{DS})$

$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ }\Omega$ ,  $T_{VJ} = 25\text{ }^\circ\text{C}$ ,  $I_{DS} = 7\text{ A}$

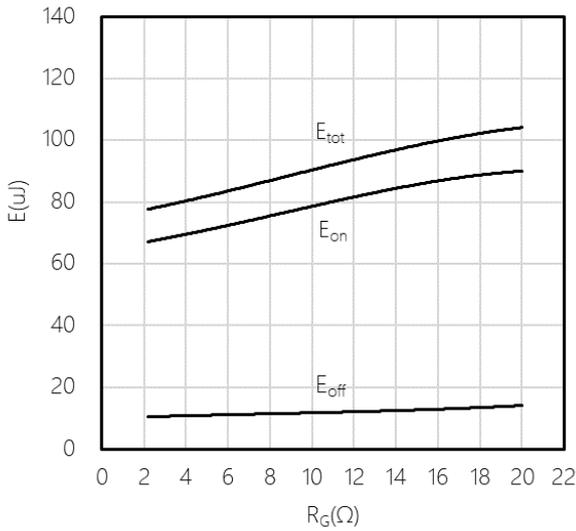


650V Silicon Carbide Power MOSFET

Typical switching energy losses as a function of gate resistance, 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(R_{G(ext)})$

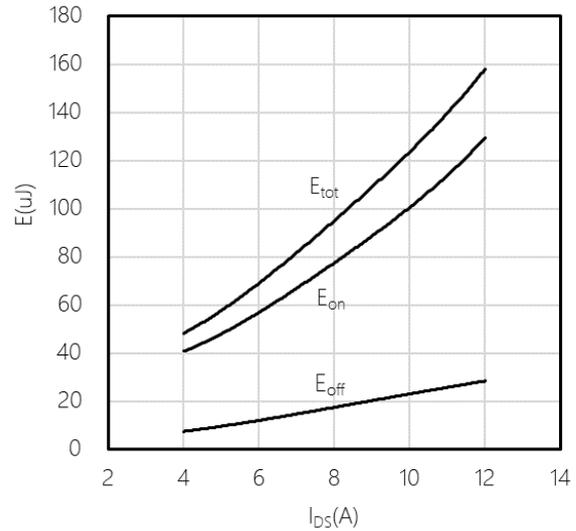
$V_{GS} = 0/15\text{ V}$ ,  $I_{DS} = 7\text{ A}$ ,  $T_{VJ} = 175\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $I_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(I_{DS})$

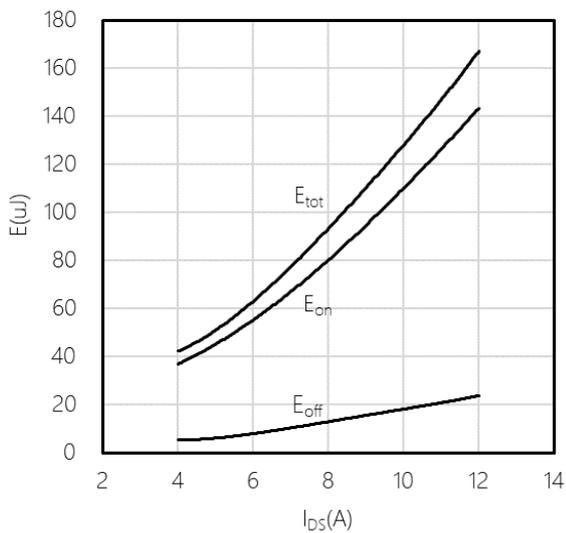
$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ } \Omega$ ,  $T_{VJ} = 25\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $I_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(I_{DS})$

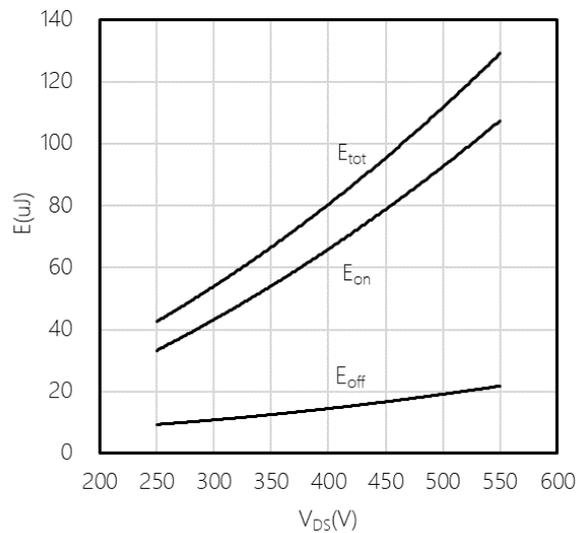
$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ } \Omega$ ,  $T_{VJ} = 175\text{ }^\circ\text{C}$ ,  $V_{DS} = 400\text{ V}$



Typical switching energy losses as a function of  $V_{DS}$ , 2nd device own body diode:  $V_{GS} = -5\text{ V}$

$E = f(V_{DS})$

$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\text{ } \Omega$ ,  $T_{VJ} = 25\text{ }^\circ\text{C}$ ,  $I_{DS} = 7\text{ A}$

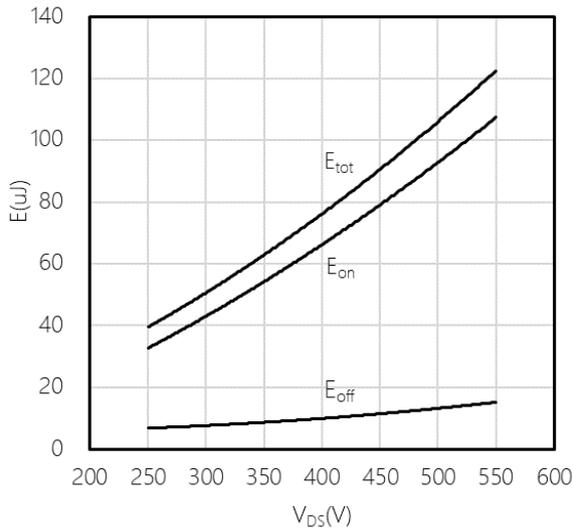


650V Silicon Carbide Power MOSFET

**Typical switching energy losses as a function of  $V_{DS}$ ,  
2nd device own body diode:  $V_{GS} = -5\text{ V}$**

$E = f(V_{DS})$

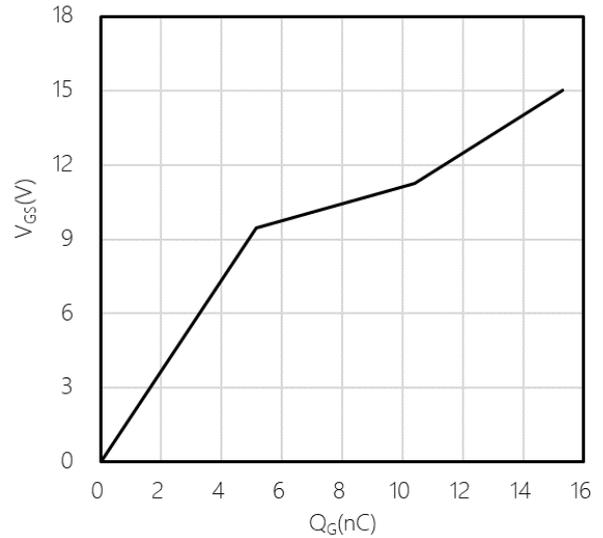
$V_{GS} = 0/15\text{ V}$ ,  $R_{G(ext)} = 2.2\ \Omega$ ,  $T_{VJ} = 175\ ^\circ\text{C}$ ,  $I_{DS} = 7\text{ A}$



**Typical gate charge**

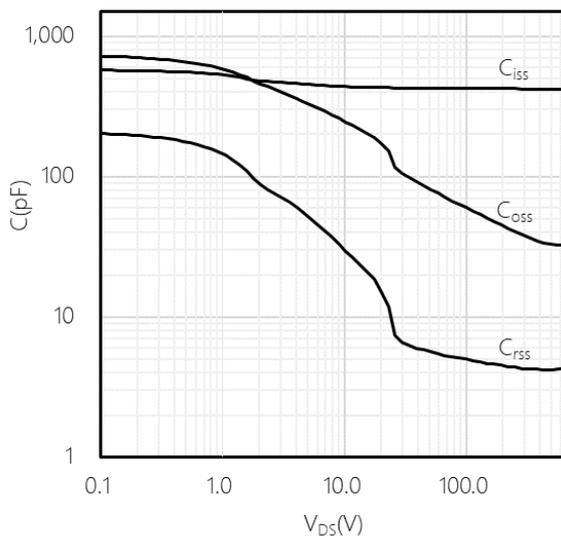
$V_{GS} = f(Q_G)$ ,  $I_{DS} = 7\text{ A}$ ,  $V_{DS} = 400\text{ V}$

turn-on pulse



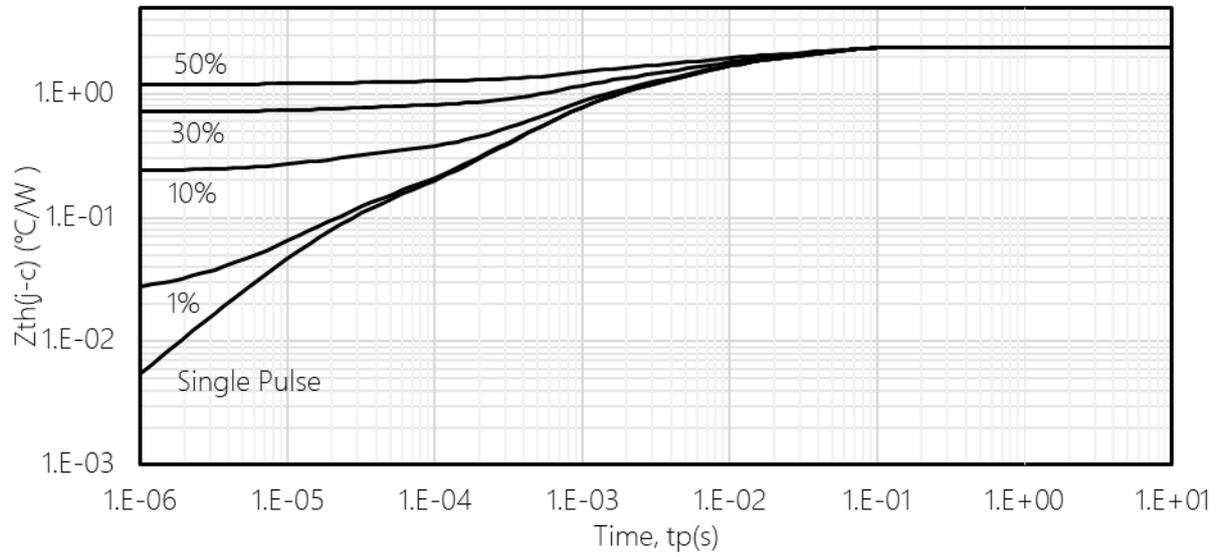
**Typical capacitance as a function of drain-source voltage**

$C = f(V_{DS})$ ,  $V_{GS} = 0\text{ V}$ ,  $f = 1\text{ MHz}$

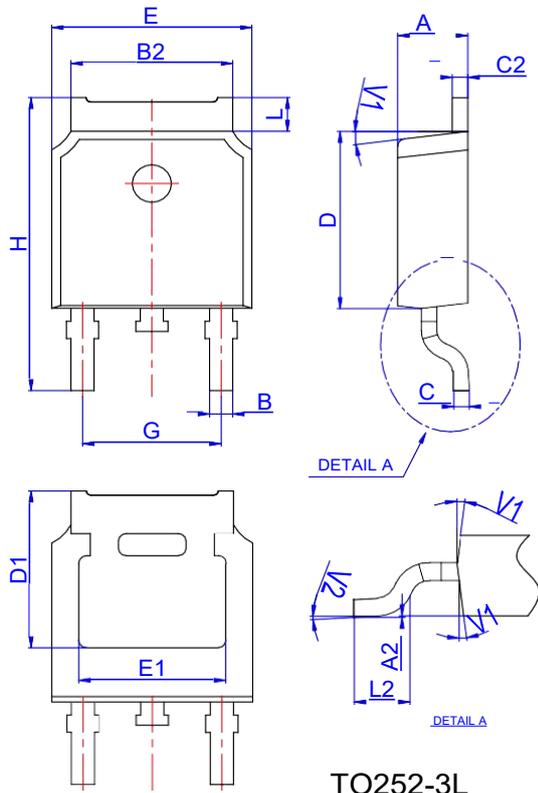


**Transient thermal resistance (MOSFET)**

$(Z_{th(j-c,max)} = f(t_p), \text{Parameter } D = t_p/T$

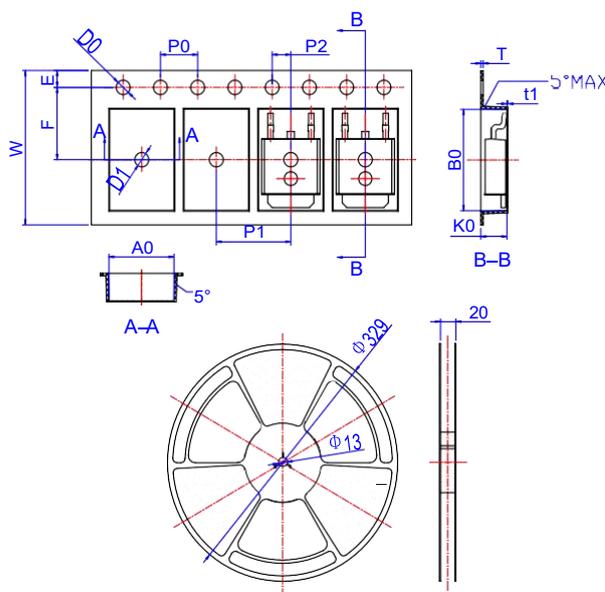


Package Dimensions



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Specification-TO252-3L



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
B0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
T	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583